



60V N-CHANNEL ENHANCEMENT MODE MOSFET H-BRIDGE

Product Summary

| BV _{DSS} | R _{DS(ON)} | I _D T _A = +25°C |
|-------------------|-------------------------------------|--|
| 60V | $22m\Omega$ @ V _{GS} = 10V | 10.6A |
| | $30m\Omega @ V_{GS} = 4.5V$ | 8.7A |

Features

- Thermally Efficient Package Cooler Running Applications
- High Conversion Efficiency
- Low R_{DS(ON)} Minimizes On-State Losses
- Low Input Capacitance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

Description

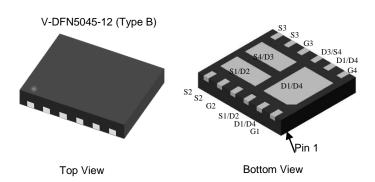
This new generation complementary MOSFET H-Bridge features low on-resistance achievable with low gate drive.

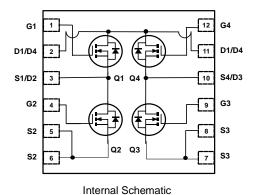
Applications

- Motor Control
- DC-DC Converters
- Power Management

Mechanical Data

- Case: V-DFN5045-12 (Type B)
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Leadframe.
 Solderable per MIL-STD-202, Method 208 @3
- Weight: 0.097 grams (Approximate)





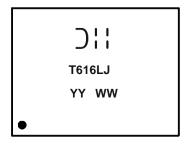
Ordering Information (Note 4)

| Part Number | Case | Packaging |
|----------------|-----------------------|-------------------|
| DMHT6016LFJ-13 | V-DFN5045-12 (Type B) | 3,000/Tape & Reel |

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



Dilamanufacturer's Marking
T616LJ = Product Type Marking Code
YYWW = Date Code Marking
YY = Last Two Digits of Year (ex: 16 = 2016)
WW = Week Code (01 to 53)



| Characteristic | Symbol | Value | Unit | | |
|---|-----------------|--|-----------------|--------------|----|
| Drain-Source Voltage | V_{DSS} | 60 | V | | |
| Gate-Source Voltage | | | V_{GSS} | ±20 | V |
| Continuous Dunis Comment (Nata C) // 40// | Steady State | $T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$ | I _D | 10.6 8.5 | А |
| Continuous Drain Current (Note 6) V _{GS} = 10V | t<10s | $T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$ | Ι _D | 14.8 11.9 | А |
| Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%) | I _{DM} | 60 | Α | | |
| Maximum Continuous Body Diode Forward Current (Note 6) | I _S | 2 | Α | | |
| Avalanche Current (Note 7) L=0.1mH | | | I _{AS} | 15.3 | Α |
| Avalanche Energy (Note 7) L=0.1mH | | | E _{AS} | 11.7 | mJ |

Thermal Characteristics

| Characteristic | | Symbol | Value | Unit |
|--|--------------|----------------------------------|-------------|------|
| Total Power Dissipation (Note 5) | | P_{D} | 1.16 | W |
| Thermal Resistance, Junction to Ambient (Note 5) | Steady State | D | 108 | °C/W |
| Thermal Resistance, Junction to Ambient (Note 5) | t<10s | R _{0JA} | 56 | C/VV |
| Total Power Dissipation (Note 6) | | P_{D} | 2.7 | W |
| Thermal Resistance, Junction to Ambient (Note 6) | Steady State | D | 46 | °C/W |
| L Thermal Resistance, Junction to Ambient (Note 6) | t<10s | $R_{\theta JA}$ | 24 | |
| Thermal Resistance, Junction to Case (Note 6) | | R ₀ JC | 4.4 | °C/W |
| Operating and Storage Temperature Range | | T _{J,} T _{STG} | -55 to +150 | °C |

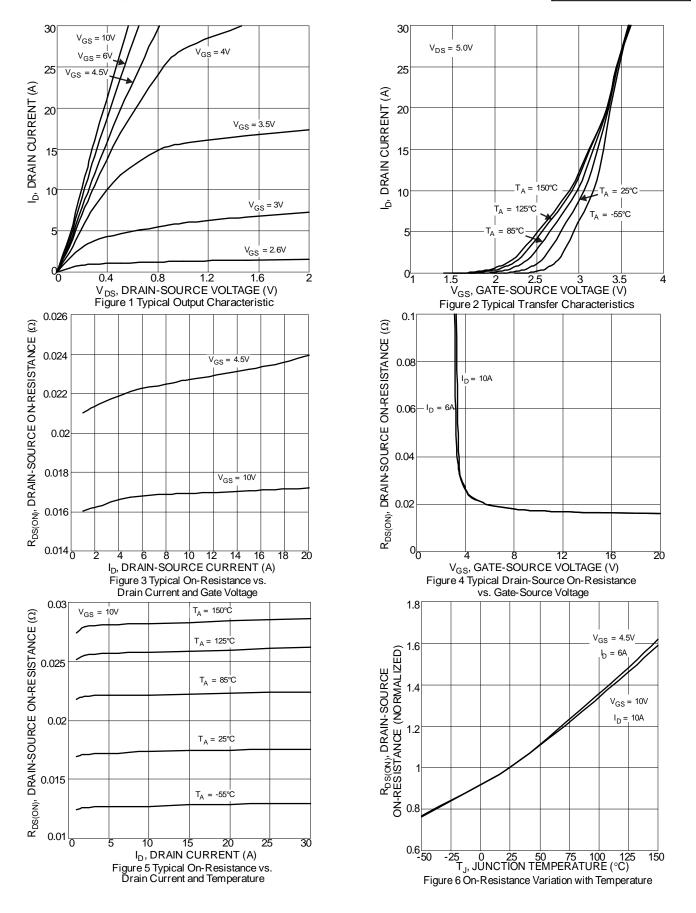
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

| Characteristic | Symbol | Min | Тур | Max | Unit | Test Condition | |
|--|---------------------|-----|---------|------|------------------------------------|---|--|
| OFF CHARACTERISTICS (Note 8) | - Cyllider | | . , , p | max | <u> </u> | root containen | |
| Drain-Source Breakdown Voltage | BV _{DSS} | 60 | _ | _ | V | $V_{GS} = 0V, I_D = 250\mu A$ | |
| Zero Gate Voltage Drain Current | I _{DSS} | | _ | 1 | μA | V _{DS} = 48V, V _{GS} = 0V | |
| Gate-Source Leakage | I _{GSS} | _ | _ | ±100 | nA | $V_{GS} = \pm 20V, V_{DS} = 0V$ | |
| ON CHARACTERISTICS (Note 8) | | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | 1 | _ | 3 | V | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$ | |
| Static Drain-Source On-Resistance | | _ | 17 | 22 | mΩ | $V_{GS} = 10V, I_D = 10A$ | |
| Static Drain-Source On-Resistance | R _{DS(ON)} | _ | 22.2 | 30 | 11177 | $V_{GS} = 4.5V, I_D = 6A$ | |
| Diode Forward Voltage | V_{SD} | _ | 0.7 | 1.2 | V | $V_{GS} = 0V, I_{S} = 1A$ | |
| DYNAMIC CHARACTERISTICS (Note 9) | • | | • | • | • | | |
| Input Capacitance | C _{ISS} | | 864 | _ | | $V_{DS} = 30V, V_{GS} = 0V,$ f = 1MHz | |
| Output Capacitance | Coss | | 282 | _ | pF | | |
| Reverse Transfer Capacitance | C _{RSS} | _ | 27 | _ | | | |
| Gate Resistance | Rg | _ | 1.3 | _ | Ω | $V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$ | |
| Total Gate Charge (V _{GS} = 4.5V) | Q _G | _ | 8.4 | _ | | | |
| Total Gate Charge (V _{GS} = 10V) | Q_{G} | _ | 17 | _ | nC | V 20V I 40A | |
| Gate-Source Charge | Q _{GS} | _ | 3.1 | _ | liC | $V_{DS} = 30V, I_{D} = 10A$ | |
| Gate-Drain Charge | Q_GD | _ | 4.3 | _ | | | |
| Turn-On Delay Time | t _{D(ON)} | | 3.4 | _ | | | |
| Turn-On Rise Time | t _R | | 5.2 | _ | | $V_{GS} = 10V, V_{DS} = 30V,$ | |
| Turn-Off Delay Time | t _{D(OFF)} | | 13 | _ | ns | $R_G = 6\Omega$, $I_D = 10A$ | |
| Turn-Off Fall Time | t _F | _ | 7 | _ | | | |
| Reverse Recovery Time | t _{RR} | | 22 | _ | ns | 1 400 11/14 4000/ | |
| Reverse Recovery Charge | Q _{RR} | _ | 11 | | $I_F = 10A$, di/dt = $100A/\mu s$ | | |

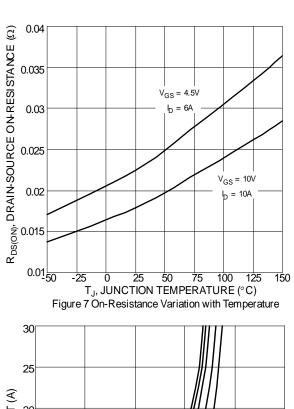
Notes: 5. Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.

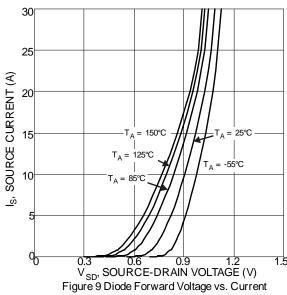
- 6. Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1-inch square copper plate.
- 7. I_{AS} and E_{AS} ratings are based on low frequency and duty cycles to keep T_J = +25°C.
 8. Short duration pulse test used to minimize self-heating effect.
 9. Guaranteed by design. Not subject to product testing.

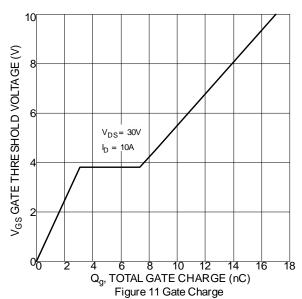












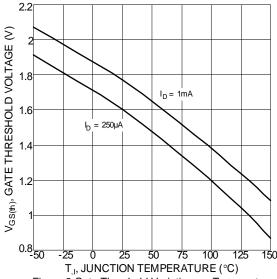
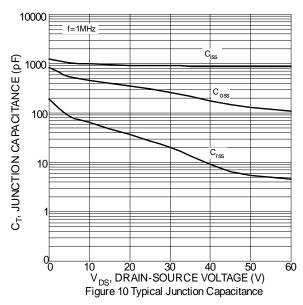
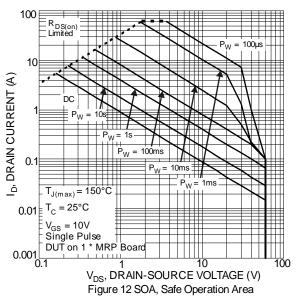
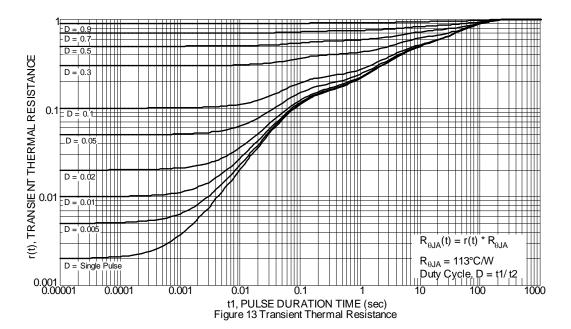


Figure 8 Gate Threshold Variation vs. Temperature







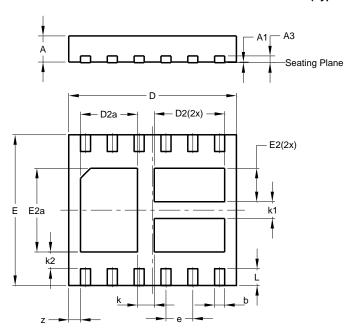




Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

V-DFN5045-12 (Type B)

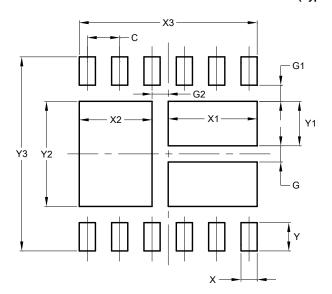


| V-DFN5045-12 | | | | | | |
|----------------------|------|------|-------|--|--|--|
| (Type B) | | | | | | |
| Dim | Min | Max | Тур | | | |
| Α | 0.75 | 0.85 | 0.80 | | | |
| A1 | 0.00 | 0.05 | 0.02 | | | |
| A3 | _ | - | 0.203 | | | |
| b | 0.25 | 0.35 | 0.30 | | | |
| D | 4.95 | 5.05 | 5.00 | | | |
| D2 | 2.00 | 2.20 | 2.10 | | | |
| D2a | 1.60 | 1.80 | 1.70 | | | |
| Е | 4.45 | 4.55 | 4.50 | | | |
| E2 | 0.90 | 1.10 | 1.00 | | | |
| E2a | 2.40 | 2.60 | 2.50 | | | |
| е | _ | - | 0.80 | | | |
| k | _ | _ | 0.50 | | | |
| k1 | _ | _ | 0.50 | | | |
| k2 | _ | _ | 0.50 | | | |
| L | 0.45 | 0.55 | 0.50 | | | |
| Z | _ | _ | 0.35 | | | |
| All Dimensions in mm | | | | | | |

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

V-DFN5045-12 (Type B)



| Dimensions | Value (in mm) |
|------------|---------------|
| С | 0.800 |
| G | 0.40 |
| G1 | 0.40 |
| G2 | 0.40 |
| Х | 0.40 |
| X1 | 2.20 |
| X2 | 1.80 |
| Х3 | 4.40 |
| Υ | 0.700 |
| Y1 | 1.100 |
| Y2 | 2.600 |
| Y3 | 4.800 |



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